



Response to a Final Rejection

Application No. 10/699/026

This communication is a response to a final rejection having a mailing date of 03/03/2006 and setting forth a shortened period for response of three month which did expire on 06/03/2006. However, applicant is requesting a two months extension of time, together with the appropriate fee, which would expire on 08/03/2006.

The applicant has studied the examiner's **DETAILED ACTION** carefully with the following results:

The objection to the disclosure because of informalities has been taken care by resubmitting the corrected paragraphs involved.

The examiner states that the objections to the disclosure as set forth on page 2 in the office action of October 6, 2005 were not addressed by the applicant. It is believed that the applicant did address the examiner's concerns. However the functions of the various elements of the Key reader will be explained again.

It can best be explained that the basic key reader 1, when inserted into a key hole to be tested it can test and determine two different criteria and, that is, to test the spacing of the various wafers that are located in the lock being tested and in a second test it can be determined how deeply the wafers will penetrate into a testing bar or bar reader. Thus then, when the reader key 1 is inserted into a lock to be tested, a wafer in that lock will slide into the slot 4. At that time a reader bar 2 is moved into the basic reader 1 and will be stopped at the wafer that has penetrated into the slot 4. The stoppage will be determined by the depth of the wafer in slot 4. The distance of the penetration of the reader bar 2 into the basic reader can be read in the opening 19b by way of the mark 5 which will read the various the various depth positions. These positions will vary with subsequent tests and different readings will be obtained. Another reading can be obtained to determine the spacing between the various wafers in the lock being tested.